DATA SHEET

TZA3050

30 Mbits/s up to 1.25 Gbits/s burst mode laser driver

Product specification

Supersedes data of 2002 Nov 06

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Philips
Semiconductors

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30 Mbits/s up to 1.25 Gbits/s burst mode laser driver **TZA3050**

CONTENTS

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1 FEATURES

1.1 General

- Burst mode laser driver from 30 Mbits/s to 1.25 Gbits/s
- Bias current from 10 mA up to 100 mA
- Modulation current from 6 mA up to 100 mA
- Switch on and off time for bias and modulation currents below 100 ns
- Integrated burst mode switching and memory circuit
- Rise and fall times typical 120 ps
- Jitter below 30 ps peak-to-peak value
- Retiming function via external clock with disable option
- Pulse width adjustment function with disable option
- Positive Emitter Coupled Logic (PECL), Low Voltage Emitter Coupled Logic (LVPECL) and Current Mode Logic (CML) compatible data and clock inputs
- Internal common mode voltage available for AC-coupled data and clock inputs and for single-ended applications
- 3.3 V supply voltage
- DC-coupled laser for 3.3 and 5 V laser supply.

1.2 Control

- Average power loop control
- Optional direct setting of bias current
- Direct setting of modulation current.

1.3 Protection

- Alarm function on operating current
- Alarm function on monitor current
- Soft start-up on bias and modulation currents during power-up.

2 APPLICATIONS

- Burst mode laser driver.

3 GENERAL DESCRIPTION

The TZA3050 is a fully integrated laser driver for burst mode optical transmission systems with data rates up to 1.25 Gbits/s. The TZA3050 incorporates all necessary control and protection functions for a laser driver application with very few external components required and low power dissipation. The average-loop controls the average monitor current in a typical programmable range from 150 to 1300 μA. The average-loop settings are memorized internally between bursts of data. The bias and modulation currents have a fast switch on and off time of less than 100 ns.

The design is made in the Philips BiCMOS RF process and is available in a HBCC32 package. The TZA3050 is intended for use in an application with a DC-coupled laser diode for both 3.3 and 5 V laser supply voltages.

The BIAS output is optimized for low voltage requirements giving a minimum of 1.25 V for 3.3 and 5 V laser supplies.

4 ORDERING INFORMATION

TYPE NUMBER	PACKAGE			
	NAME	DESCRIPTION		VERSION
TZA3050VH	HBCC32	plastic, heatsink bottom chip carrier; 32 terminals; body 5 × 5 × 0.65 mm		SOT560-1

5 BLOCK DIAGRAM

Fig.1 Block diagram.

6 PINNING

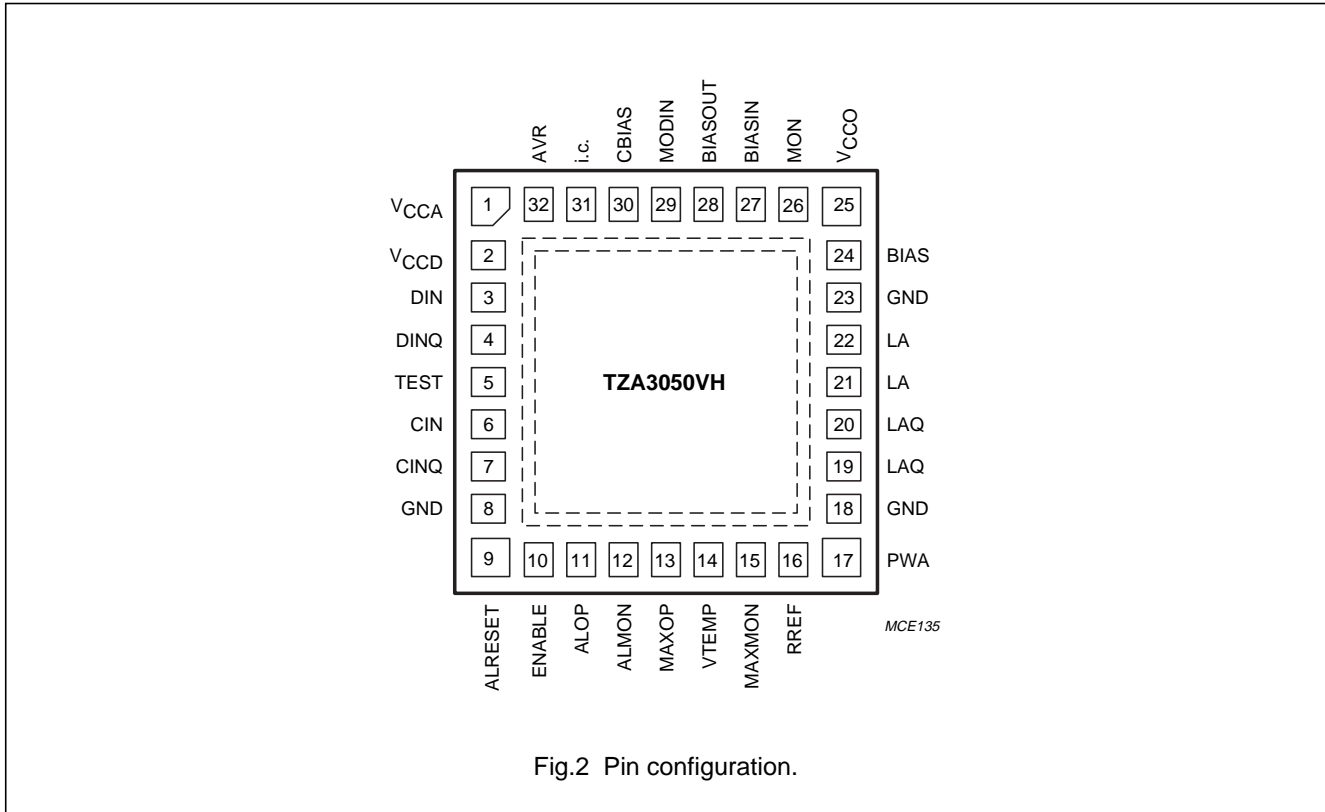| SYMBOL	PIN	DESCRIPTION
GND	die pad	common ground plane for V_{CCA}, V_{CCD}, V_{CCO}, RF and I/O; must be connected to ground
V_{CCA}	1	analog supply voltage
V_{CCD}	2	digital supply voltage
DIN	3	non-inverted data input (RF input)
DINQ	4	inverted data input (RF input)
TEST	5	test pin; must be connected to ground
CIN	6	non-inverted clock input (RF input)
CINQ	7	inverted clock input (RF input)
GND	8	ground
ALRESET	9	alarm reset input for alarm outputs ALMON and ALOP
ENABLE	10	enable input for modulation and bias current switch on and off between bursts
ALOP	11	alarm output on operating current (open-drain)
ALMON	12	alarm output on monitor diode current (open-drain)
MAXOP	13	threshold level input for alarm on operating current
VTEMP	14	temperature dependent voltage output
MAXMON	15	threshold level input for alarm on monitor diode current
RREF	16	reference current input; must be connected to ground with an accurate (1%) 10 kΩ resistor
PWA	17	pulse width adjustment input
GND	18	ground
LAQ	19	inverted laser modulation output (RF output); output for dummy load
LAQ	20	inverted laser modulation output (RF output); output for dummy load
LA	21	non-inverted laser modulation output (RF output); output for laser
LA	22	non-inverted laser modulation output (RF output); output for laser
GND	23	ground
BIAS	24	current source output for the laser bias current
V_{CCO}	25	supply voltage for the output stage and the laser diode
MON	26	input from the monitor photodiode (RF input)
BIASIN	27	input for the bias current setting
BIASOUT	28	output of the control block for the bias current
MODIN	29	input for the modulation current setting
CBIAS	30	output of the average loop; must be connected via a 100 nF external capacitor to GND
i.c.	31	internally connected
AVR	32	input for the optical average power level setting

Fig.2 Pin configuration.

7 FUNCTIONAL DESCRIPTION

7.1 Data and clock input

The TZA3050 operates with differential Positive Emitter Coupled Logic (PECL), Low Voltage Positive Emitter Coupled Logic (LVPECL) and Current-Mode Logic (CML) data and clock inputs with a voltage swing from 100 mV to 1 V (p-p). It is assumed that both data and clock inputs carry a complementary signal with the specified peak-to-peak value (true differential excitation).

The circuit generates an internal common mode voltage for AC-coupled data inputs, clock inputs and single-ended applications.

If $V_{DIN} > V_{DINQ}$, the modulation current is sunk by pin LA and corresponds to an optical 'one' level of the laser.

7.2 Retiming

The retiming function synchronizes the data with the clock to improve the jitter performance. The data latch switches on the rising edge of the clock input. The retiming function is disabled when both clock inputs are below 0.3 V.

At start-up the initial polarity of the laser is unknown until the first rising edge of the clock input appears.

7.3 Pulse width adjustment

The on-duration of the laser current can be adjusted with a guaranteed range from −50 to +50 ps. The adjustment time is set by connecting a resistor, R_{PWA}, to pin PWA. The maximum allowable capacitive load on pin PWA is 100 pF. Pulse width adjustment is disabled when pin PWA is short-circuited to ground.

7.4 Modulator output stage

The output stage is a high-speed bipolar differential pair with typical rise and fall times of 120 ps and with a modulation current source of up to 100 mA. The output stage of the TZA3050 is optimized for DC-coupled lasers.

The modulation current switches between the LA and LAQ outputs. For a good RF performance the inactive branch carries a small amount of the modulation current.

The LA output is optimized for the laser, the LAQ output is optimized for the dummy load.

The BIAS output is optimized for low voltage requirements (1.25 V minimum).

7.5 Average loop control

The average power control loop maintains a constant average power level of the monitor current over temperature and lifetime of the laser. The average monitor current is programmable over a wide current range, from 150 to 1 300 μA typical, by tuning the setting resistor R_{AVR}. The maximum allowable capacitive load on pins AVR and BIASOUT is 100 pF.

7.6 Direct current setting

The TZA3050 can also operate in open-loop mode with direct setting of the bias and modulation currents. The bias and modulation current sources are transconductance amplifiers and the output currents are determined by the BIASIN and MODIN voltages respectively. The bias current source has a bipolar output stage with minimum output capacitance for optimum RF performance.

7.7 Soft start

At power-up the bias and modulation current sources are released when $V_{CCA} > 2.7$ V, the reference voltage has reached the correct value of 1.2 V and the voltage on pin ENABLE is HIGH.

The control loop starts with minimum bias and modulation current at power-up provided the device is enabled. The current levels increase until the input current on pin MON matches the programmed average level.

7.8 Burst mode

The TZA3050 is compliant with burst mode application. Fast switch on and off of bias and modulation currents is allowed in less than 100 ns via pin ENABLE.

When internal average loop control is used, the average power settings can be maintained between two bursts of data via an external capacitor on pin CBIAS.

During a burst, this capacitor defines the time constant of the loop. Between bursts, the capacitor is automatically disconnected from the internal circuitry and is used as a memory cell.

A more complex memory cell can also be connected to pin CBIAS.

7.9 Alarm functions

The TZA3050 features two alarm functions for the detection of excessive laser operating current and monitor diode current due to laser ageing, laser malfunctioning or a high laser temperature. The alarm threshold levels are programmed by a resistor or a current source. The operating current equals the bias current plus half of the modulation current.

7.10 Enable

A LOW level on the enable input disables the bias and modulation current sources: the laser is off. A HIGH level on the enable input or an open enable input switches both current sources on: the laser is operational.

7.11 Reference block

The reference voltage is derived from a band gap circuit and is available at pin RREF. An accurate (1%) 10 kΩ resistor has to be connected to pin RREF to provide the internal reference current. The maximum allowable capacitive load on pin RREF is 100 pF.

The reference voltage on the setting pins MAXOP, MAXMON, PWA and AVR is buffered and derived from the band gap voltage.

The output voltage on pin VTEMP reflects the junction temperature of the TZA3050. The temperature coefficient of V_{VTEMP} equals -2.2 mV/K.

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8 LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134); all voltages are referenced to ground; positive currents flow into the IC.

SYMBOL	PARAMETER	CONDITION	MIN.	MAX.	UNIT
V_{CCD}	digital supply voltage		−0.5	+3.5	V
V_{CCA}	analog supply voltage		−0.5	+3.5	V
V_{CCO}	RF output supply voltage	3.3 V laser supply	−0.5	+3.5	V
		5 V laser supply	−0.5	+5.3	V
$V_{o(LA)}$	output voltage at pin LA	V_{CCO} = 3.3 V	0.8	4.1	V
		V_{CCO} = 5 V	1.2	4.5	V
$V_{o(LAQ)}$	output voltage at pin LAQ	V_{CCO} = 3.3 V	1.6	4.5	V
		V_{CCO} = 5 V	2.0	5.2	V
V_{BIAS}	bias voltage	V_{CCO} = 3.3 V	0.8	3.6	V
		V_{CCO} = 5 V	0.8	4.1	V
V_n	voltage on all other input and output pins				
	analog inputs and outputs		−0.5	V_{CCA} + 0.5	V
	digital inputs and outputs		−0.5	V_{CCD} + 0.5	V
I_n	input current on pins				
	MAXOP, MAXMON, RREF, PWA and AVR		−1.0	0	mA
	VTEMP and BIASOUT		−1.0	+1.0	mA
	ALOP, ALMON and MON		0	5.0	mA
T_{amb}	ambient temperature		−40	+85	°C
T_j	junction temperature		−40	+125	°C
T_{stg}	storage temperature		−65	+150	°C

9 THERMAL CHARACTERISTICS

In compliance with JEDEC standards JESD51-5 and JESD51-7.

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
$R_{th(j-a)}$	thermal resistance from junction to ambient	4 layer Printed-circuit board in still air with 9 plated vias connected with the heatsink and the first ground plane in the PCB	35	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient	HBCC32 die pad soldered to PCB	60	K/W

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10 DC CHARACTERISTICS

T_{amb} = −40 to +85 °C; $R_{th(j-a)}$ = 35 K/W; P_{tot} = 400 mW; V_{CCA} = 3.14 to 3.47 V; V_{CCD} = 3.14 to 3.47 V;
V_{CCO} = 3.14 to 3.47 V; R_{AVR} = 7.5 kΩ; R_{MODIN} = 6.2 kΩ; R_{BIASIN} = 6.8 kΩ; R_{PWA} = 10 kΩ; R_{RREF} = 10 kΩ (1%);
R_{MAXMON} = 13 kΩ; R_{MAXOP} = 20 kΩ; positive currents flow into the IC; all voltages are referenced to ground; unless
otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Supplies: pins V$_{CCA}$, V$_{CCD}$ and V$_{CCO}$						
V_{CCA}	analog supply voltage		3.14	3.3	3.47	V
V_{CCD}	digital supply voltage		3.14	3.3	3.47	V
V_{CCO}	RF output supply voltage	3.3 V laser supply	3.14	3.3	3.47	V
		5 V laser supply	4.75	5.0	5.25	V
I_{CCA}	analog supply current		–	40	55	mA
I_{CCD}	digital supply current		–	45	60	mA
I_{CCO}	RF output supply current	pins LA and LAQ open-circuit; 3.3 and 5 V laser supply	–	20	30	mA
P_{tot}	total power dissipation	V_{BIAS} = 3.3 V; I_{mod} = 16 mA; I_{BIAS} = 20 mA; note 1	–	412	–	mW
P_{core}	core power dissipation	excluding $I_{o(LA)}$, $I_{o(LAQ)}$ and I_{BIAS}; PWA and retiming off	–	264	–	mW
Data and clock inputs: pins DIN and CIN						
$V_{i(p-p)}$	input voltage swing (peak-to-peak value)	$V_{i(DIN)}$ = V_{CCD} − 2 V to V_{CCD}; $V_{i(CIN)}$ = V_{CCD} − 2 V to V_{CCD}	100	–	1000	mV
$V_{int(cm)}$	internal common mode voltage	AC-coupled inputs	–	V_{CCD} − 1.32	–	V
V_{IO}	input offset voltage	note 2	−10	0	+10	mV
$Z_{i(dif)}$	differential input impedance		80	100	130	Ω
$Z_{i(cm)}$	common mode input impedance		–	10	–	kΩ
$V_{i(CIN)(dis)}$	input voltage for disabled retiming	V_{CIN} = V_{CINQ}	–	–	0.3	V
Monitor photodiode input: pin MON						
$V_{i(MON)}$	input voltage	I_{av} = 150 to 1300 µA	0.9	1.1	1.3	V
$Z_{i(MON)}$	input impedance	I_{av} = 150 to 1300 µA	–	27	–	Ω
Setting for average loop control: pins MON and AVR						
$I_{av(MON)(low)}$	low average monitor current setting	I_{AVR} > −250 µA	–	–	150	µA
$I_{av(MON)(max)}$	maximum average monitor current setting	I_{AVR} = −50 µA	1150	1300	–	µA
$\Delta I_{av(MON)}$	relative accuracy of average current on pin MON	temperature and V_{CCA} variations; I_{AVR} = 550 µA	−10	–	+10	%
$V_{ref(AVR)}$	reference voltage on pin AVR	I_{AVR} = −250 to −15 µA; C_{AVR} < 100 pF	1.14	1.20	1.26	V

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$I_{sink(AVR)}$	current sink on pin AVR		−280	–	−15	µA
Control loop bias output: pin BIASOUT						
$I_{source(BIASOUT)}$	source current	$V_{BIASOUT}$ = 0.5 to 1.5 V; $C_{BIASOUT}$ < 100 pF	–	–	−200	µA
$I_{sink(BIASOUT)}$	sink current	$V_{BIASOUT}$ = 0.5 to 1.5 V; $C_{BIASOUT}$ < 100 pF	200	–	–	µA
Bias current source: pins BIASIN and BIAS						
$g_{m(bias)}$	bias transconductance	V_{BIASIN} = 0.5 to 1.5 V; $V_{BIAS} = V_{CCO}$	89	110	131	mA/V
$I_{source(BIASIN)}$	source current at pin BIASIN	V_{BIASIN} = 0.5 to 1.5 V	−110	−100	−95	µA
$I_{BIAS(max)}$	maximum bias current	V_{BIASIN} = 1.8 V	100	–	–	mA
$I_{BIAS(min)}$	minimum bias current	V_{BIASIN} = 0 to 0.4 V	–	0.2	0.4	mA
$I_{BIAS(dis)}$	bias current at disable	V_{ENABLE} < 0.8 V	–	–	100	µA
$V_{o(BIAS)}$	output voltage on pin BIAS		1.25	–	–	V
Modulation current source: pin MODIN						
$g_{m(mod)}$	modulation transconductance	V_{MODIN} = 0.5 to 1.5 V; $V_{LA} = V_{LAQ} = V_{CCO}$	77	95	112	mA/V
$I_{source(MODIN)}$	source current at pin MODIN	V_{MODIN} = 0.5 to 1.5 V	−110	−100	−95	µA
Modulation current outputs: pins LA and LAQ						
$I_{o(LA)(max)(on)}$	maximum laser modulation output current at LA on	V_{MODIN} = 1.8 V; $V_{LA} = V_{CCO}$ = 3.3 V; note 3	100	–	–	mA
$I_{o(LA)(min)(on)}$	minimum laser modulation output current at LA on	V_{MODIN} = 0 to 0.4 V; $V_{LA} = V_{CCO}$ = 3.3 V; note 3	–	5	6	mA
$I_{o(LA)(min)(off)}$	minimum laser modulation output current at LA off	V_{MODIN} = 1.5 V; $V_{LA} = V_{CCO}$ = 3.3 V; note 3	–	–	2	mA
$Z_{o(LA)}$, $Z_{o(LAQ)}$	output impedance LA and LAQ pins		80	100	130	Ω
$I_{o(LA)(dis)}$, $I_{o(LAQ)(dis)}$	non-inverted and inverted laser modulation output current at disable	V_{ENABLE} < 0.8 V	–	–	200	µA
$V_{o(LA)(min)}$	minimum output voltage at pin LA	V_{CCO} = 3.3 V	1.2	–	–	V
		V_{CCO} = 5 V	1.6	–	–	V
Enable function: pin ENABLE						
V_{IL}	LOW-level input voltage	bias and modulation currents disabled	–	–	0.8	V
V_{IH}	HIGH-level input voltage	bias and modulation currents enabled	2.0	–	–	V
$R_{pu(int)}$	internal pull-up resistance		–	20	–	kΩ

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SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Alarm reset: pin ALRESET						
V_{IL}	LOW-level input voltage	no reset	–	–	0.8	V
V_{IH}	HIGH-level input voltage	reset	2.0	–	–	V
$R_{pd(int)}$	internal pull-down resistance		–	10	–	kΩ
Alarm operating current: pins MAXOP and ALOP						
$V_{ref(MAXOP)}$	reference voltage on pin MAXOP	I_{MAXOP} = 10 to 200 µA	1.15	1.2	1.25	V
N_{MAXOP}	ratio of $I_{oper(alarm)}$ and I_{MAXOP}	$I_{oper(alarm)}$ = 7.5 to 150 mA	–	775	–	
$V_{D(ALOP)L}$	drain voltage at active alarm	I_{ALOP} = 500 µA	0	–	0.4	V
Alarm monitor current: pins MAXMON and ALMON						
$V_{ref(MAXMON)}$	reference voltage on pin MAXMON	I_{MAXMON} = 10 to 200 µA	1.15	1.2	1.25	V
N_{MAXMON}	ratio of $I_{MON(alarm)}$ and I_{MAXMON}	$I_{MON(alarm)}$ = 150 to 3000 µA	–	15	–	
$V_{D(ALMON)L}$	drain voltage at active alarm	I_{ALMON} = 500 µA	0	–	0.4	V
Reference block: pins RREF and VTEMP						
V_{RREF}	reference voltage	R_{RREF} = 10 kΩ (1%); C_{RREF} < 100 pF	1.15	1.20	1.25	V
V_{VTEMP}	temperature dependent voltage	T_j = 25 °C; C_{VTEMP} < 2 nF; note 4	1.14	1.20	1.27	V
TC_{VTEMP}	temperature coefficient of V_{VTEMP}	T_j = –25 to + 125 °C; note 4	–	–2.2	–	mV/K
$I_{source(VTEMP)}$	source current of pin VTEMP		–	–	–1	mA
$I_{sink(VTEMP)}$	sink current of pin VTEMP		1	–	–	mA

Notes

1. The total power dissipation P_{tot} is calculated with $V_{BIAS} = V_{CCO}$ = 3.3 V and I_{BIAS} = 20 mA. In the application V_{BIAS} will be V_{CCO} minus the laser diode voltage which results in a lower total power dissipation.

2. The specification of the offset voltage is guaranteed by design.

3. The relation between the sink current $I_{o(LA)}$ and the modulation current I_{mod} is: $I_{o(LA)} = I_{mod} \times \dfrac{100}{100 + Z_{L(LA)}}$ where

    $Z_{L(LA)}$ is the external load on pin LA. The voltage on pin MODIN programmes the modulation current I_{mod}. This current is divided between $Z_{L(LA)}$ and the 100 Ω internal resistor connected to pins LA. When the modulation current is programmed to 100 mA, a typical $Z_{L(LA)}$ of 25 Ω will result in an $I_{o(LA)}$ current of 80 mA, while 20 mA flows via the internal resistor. This corresponds to a voltage swing of 2 V on the real application load.

4. $V_{VTEMP} = 1.31 + TC_{VTEMP} \times T_j$ and $T_j = T_{amb} + P_{tot} \times R_{th(j-a)}$.

11 AC CHARACTERISTICS

T_{amb} = −40 to +85 °C; $R_{th(j-a)}$ = 35 K/W; P_{tot} = 420 mW; V_{CCA} = 3.14 to 3.47 V; V_{CCD} = 3.14 to 3.47 V; V_{CCO} = 3.14 to 3.47 V; R_{AVR} = 7.5 kΩ; R_{MODIN} = 6.2 kΩ; R_{BIASIN} = 6.8 kΩ; R_{PWA} = 10 kΩ; R_{RREF} = 10 kΩ (1%); R_{MAXMON} = 13 kΩ; R_{MAXOP} = 20 kΩ; positive currents flow into the IC; all voltages are referenced to ground; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
RF path						
BR	bit rate	average loop control	0.03	–	1.25	Gbits/s
$J_{(LA)(p-p)}$	jitter of pin LA output signal (peak-to-peak value)	R_L = 25 Ω	–	–	30	ps
t_r, t_f	rise and fall time of voltage on pin LA	20% to 80%; R_L = 25 Ω; I_{mod} = 30 mA	–	120	150	ps
$t_{su(D)}$	data input set-up time		60	–	–	ps
$t_{h(D)}$	data input hold time		60	–	–	ps
$t_{o(en)}$	switch-on time at enable	from 50% of enable to 90% of steady state typical bias and modulation current; note 1	–	–	100	ns
$t_{o(dis)}$	switch-off time at disable	from 50% of enable to 10% of steady state typical bias and modulation current; note 1	–	–	100	ns
Current control						
tc_{int}	average loop time constant	average loop control; C_{CBIAS} = 100 nF	–	5	–	ms
$t_{burst(min)}$	minimum burst time	ENABLE pin HIGH	30	–	–	μs
$t_{idle(max)}$	maximum time between two bursts	ENABLE pin LOW	–	–	8	ms
Pulse width adjustment						
$t_{PWA(min)}$	minimum pulse width adjustment on pins LA	R_{PWA} = 6.7 kΩ; C_{PWA} < 100 pF	–	−100	−50	ps
t_{PWA}	pulse width adjustment on pins LA	R_{PWA} = 10 kΩ; C_{PWA} < 100 pF	–	0	–	ps
$t_{PWA(max)}$	maximum pulse width adjustment on pins LA	R_{PWA} = 20 kΩ; C_{PWA} < 100 pF	50	100	–	ps

Note

1. The switch-on and switch-off time at enable and disable given are the absolute maximum values. They depend strongly on the following parameters: bias current, modulation current, bias inductance and laser supply voltage. More detailed information available upon request

12 APPLICATION INFORMATION

12.1 Design equations

12.1.1 BIAS AND MODULATION CURRENTS

The bias and modulation currents are determined by the voltages on pins BIASIN and MODIN. For average loop control the BIASIN voltage is applied by the BIASOUT pin and the MODIN voltage is applied by an external voltage source or an external resistor R_{MODIN}.
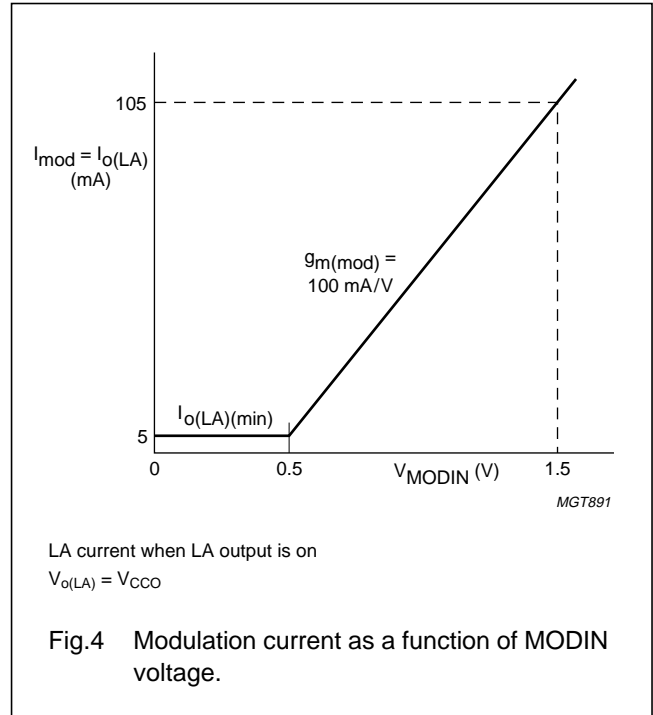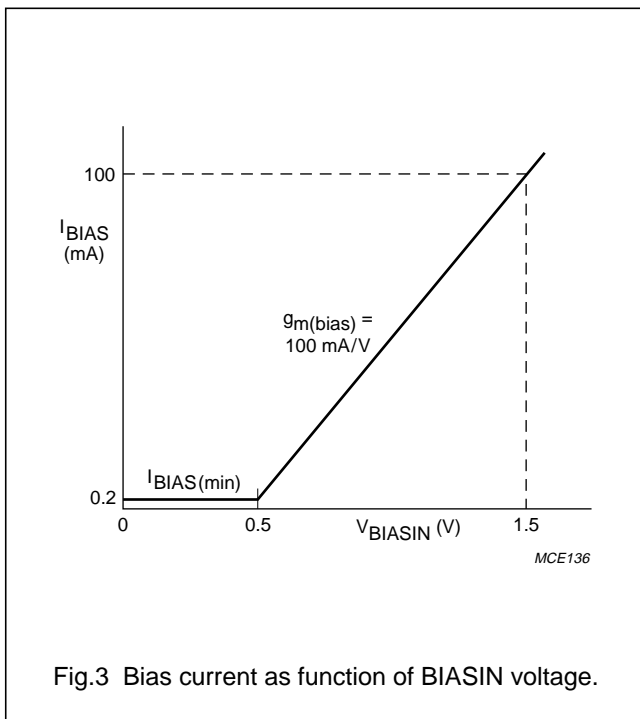
For direct setting of bias and modulation currents, the BIASIN and MODIN voltages have to be applied by external voltage sources or by external resistors R_{BIASIN} and R_{MODIN} connected to the BIASIN and MODIN pins:

$I_{BIAS} = (R_{BIASIN} \times 100\ \mu A - 0.5\ V) \times g_{m(bias)}$ [mA]

$I_{mod} = (R_{MODIN} \times 100\ \mu A - 0.5\ V) \times g_{m(mod)} + 5$ [mA]

The transconductance $g_{m(mod)}$ defines the relation between the voltage on pin MODIN and the modulation current.

The bias and modulation current sources operate with an input voltage range from 0.5 to 1.5 V. The output current is at its minimum level for an input voltage below 0.4 V; see Figs 3 and 4. The graphs indicate the values with a load of 0 Ω. When the load is not zero, the relation between $I_{o(LA)}$ and I_{mod} is given in Table "DC characteristics" Note 3.

Fig.3 Bias current as function of BIASIN voltage.

LA current when LA output is on
$V_{o(LA)} = V_{CCO}$

Fig.4   Modulation current as a function of MODIN voltage.

12.1.2 AVERAGE MONITOR CURRENT

The bias and modulation current sources are temperature compensated and keep the adjusted current level stable over the temperature range.

The bias and modulation currents increase with increasing resistor values for R_{BIASIN} and R_{MODIN} respectively; this allows resistor tuning to start at a minimum current level.

The average monitor current $I_{av(MON)}$ in average loop operation is determined by the source current of the AVR pin (I_{AVR}). The current can be sunk by an external current source or by an external resistor, R_{AVR}, connected to ground. The equation is:

$$I_{av(MON)} = 1580 - 5.26 \times I_{AVR} = 1580 - 5.26 \times \frac{V_{AVR}}{R_{AVR}}\ [\mu A]$$

The average monitor current increases with decreasing I_{AVR} or increasing R_{AVR}; this allows resistor tuning of R_{AVR} to start at minimum I_{AVR} current level (see Fig.5).

The formula used to program AVR is valid for typical conditions; tuning is necessary to achieve absolute accuracy of the AVR value.
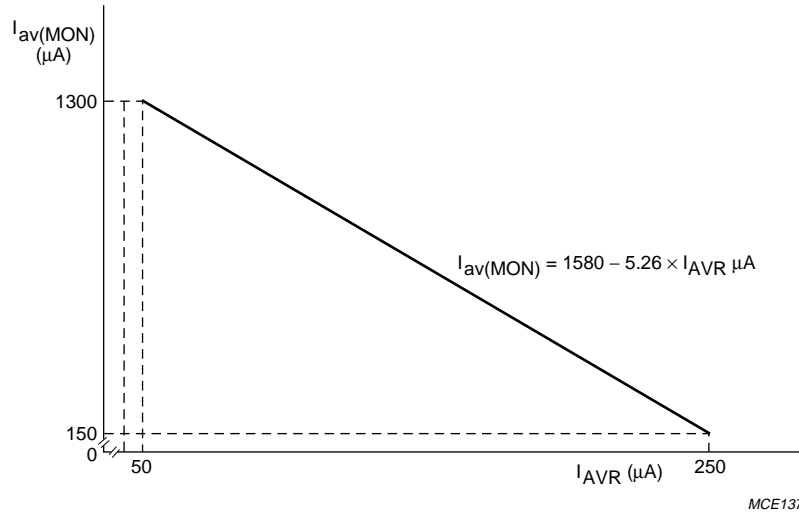
Fig.5 Typical average monitor current as a function of I_{AVR}.

12.1.3 ALARM OPERATING CURRENT

The operating current for the DC-coupled laser application equals the bias current plus half of the modulation current:

$$I_{oper} = I_{BIAS} + \frac{I_{mod}}{2}$$

The alarm threshold $I_{oper(alarm)}$ on the operating current is determined by the source current of the MAXOP pin. The current range for I_{MAXOP} is from 10 to 200 μA which corresponds with an $I_{oper(alarm)}$ from 7.5 to 150 mA. The I_{MAXOP} current can be sunk by an external current source or by connecting R_{MAXOP} to ground:

$$I_{oper(alarm)} = N_{MAXOP} \times \frac{V_{MAXOP}}{R_{MAXOP}}$$

The detection level is independent from burst mode timing.

12.1.4 ALARM MONITOR CURRENT

The alarm threshold $I_{MON(alarm)}$ on the monitor current is determined by the source current of the MAXMON pin. The current range for I_{MAXMON} is from 10 to 200 μA, which corresponds with an $I_{MON(alarm)}$ from 150 to 3000 μA. The I_{MAXMON} current can be sunk by an external current source or by connecting R_{MAXMON} to ground:

$$I_{MON(alarm)} = N_{MAXMON} \times \frac{V_{MAXMON}}{R_{MAXMON}}$$

As the detected I_{MON} is an average current, the alarm threshold is a function of the burst mode timing. The formula can be used as a reference for a mode where signal is always present.
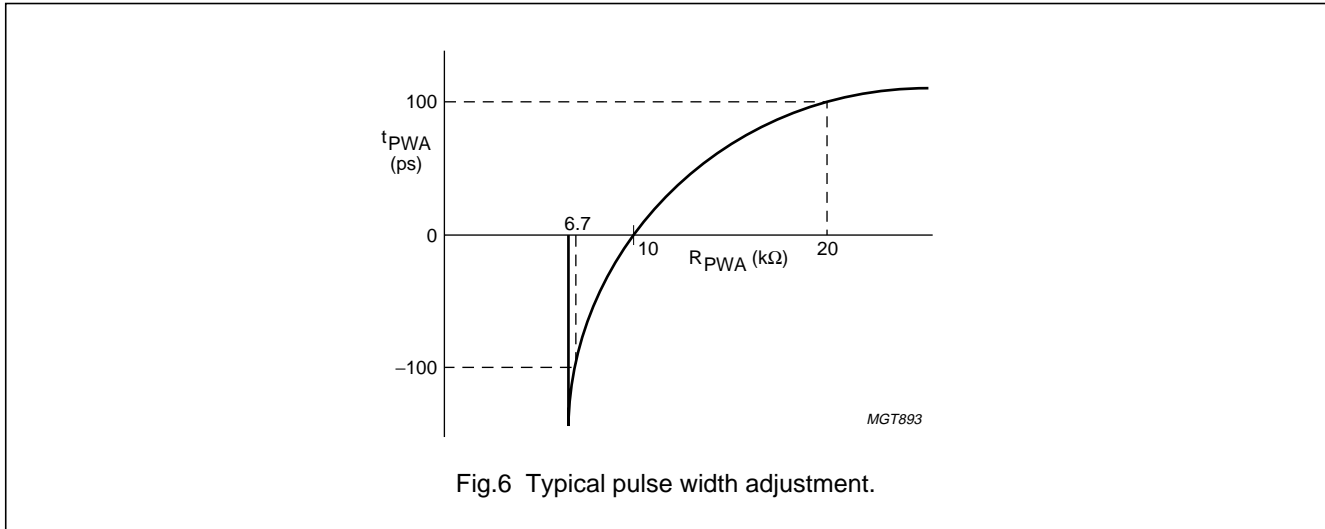
12.1.5 PULSE WIDTH ADJUSTMENT

The pulse width adjustment time is determined by resistor R_{PWA}:

$$t_{PWA} = 200 \times \frac{R_{PWA} - 10 \text{ k}\Omega}{R_{PWA}} \text{ [ps]}$$

The t_{PWA} typical range is from −100 to +100 ps, which corresponds with an R_{PWA} resistance ranging from 6.7 kΩ minimum to 20 kΩ maximum (see Fig.6). The PWA function is disabled when the PWA input is short-circuited to ground, the t_{PWA} is 0 ps for a disabled PWA function.

Fig.6 Typical pulse width adjustment.

12.2 Burst mode application

In burst mode application, data flow is not constant, data (the 'burst') is interrupted with significant idle times when no data is present and the laser is shut-down.

When using average loop control, the control is only done during a burst of data and the average value should be stored during idle time.

The TZA3050 requires only one external capacitor to perform this storage. A typical 100 nF lossless capacitor connected to pin CBIAS will define the time constant of the loop during bursts (typical 5 ms) and will also define the accuracy of the value stored between bursts. Tuning of the external capacitor allows tuning of the average loop time constant depending on the duty cycle and the burst duration.

When pin ENABLE is LOW, an internal switch is opened and the external capacitor is connected to a high-impedance point. When pin ENABLE is HIGH, the internal switch is closed and the external capacitor is connected to the internal average loop control circuit.
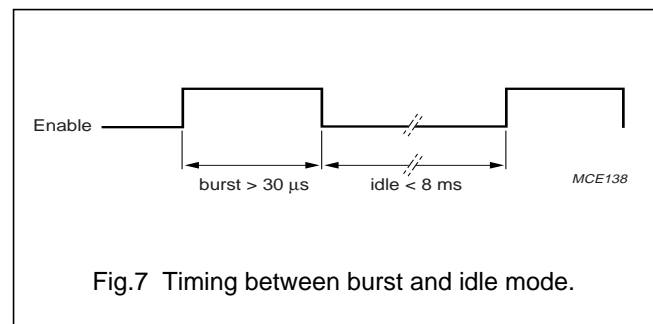
The ENABLE pin also controls the on and off switch state of the bias and modulation current output stages resulting in burst-to-idle and idle-to-burst times below 100 ns on the full current range available, with a typical load of 25 Ω on pins LA and LAQ.

It is not recommended to use the TZA3050 without an external capacitor on pin CBIAS as this would result in a too small time constant, with the risk of pattern dependent behaviour. Table 1 shows time constants for different CBIAS capacitors.

Table 1 Typical time constant of the average loop

CAPACITOR C_{CBIAS}	TIME CONSTANT (TYP.)
10 nF	<1 ms
100 nF	5 ms
470 nF	30 ms

Using a smaller CBIAS capacitor allows a faster loop recovery in short burst period applications, but it also means a shorter storage period. A 100 nF is considered as a convenient value, even in applications with short burst time (minimum 30 μs), and large idle time (maximum 8 ms) applications as shown in Fig.7.

Fig.7 Timing between burst and idle mode.

At power-up, the memorized value on pin CBIAS is reset by connecting pin CBIAS internally to ground. The timing in Fig.7 does not take into account the initial charging of the storage circuit. This initial timing is directly proportional to the value of the CBIAS capacitor and to the duty cycle settings of the application.

12.3 Average loop control

A simplified application using the TZA3050 with average loop control and a DC-coupled laser at 3.3 or 5 V laser voltage is illustrated in Fig.8. The average power level is determined by the resistor R_{AVR}. The average loop controls the bias current with the BIASOUT output connected to the BIASIN input. The modulation current is determined by the MODIN input voltage, which is generated by the resistor R_{MODIN} and the 100 μA source current of the MODIN pin.

The average loop setting is maintained between bursts with a capacitor connected to pin CBIAS. When pin ENABLE is HIGH, the internal average loop regulates the average power. When pin ENABLE is LOW, an internal switch is opened and the previous average loop state is stored on the CBIAS capacitor.
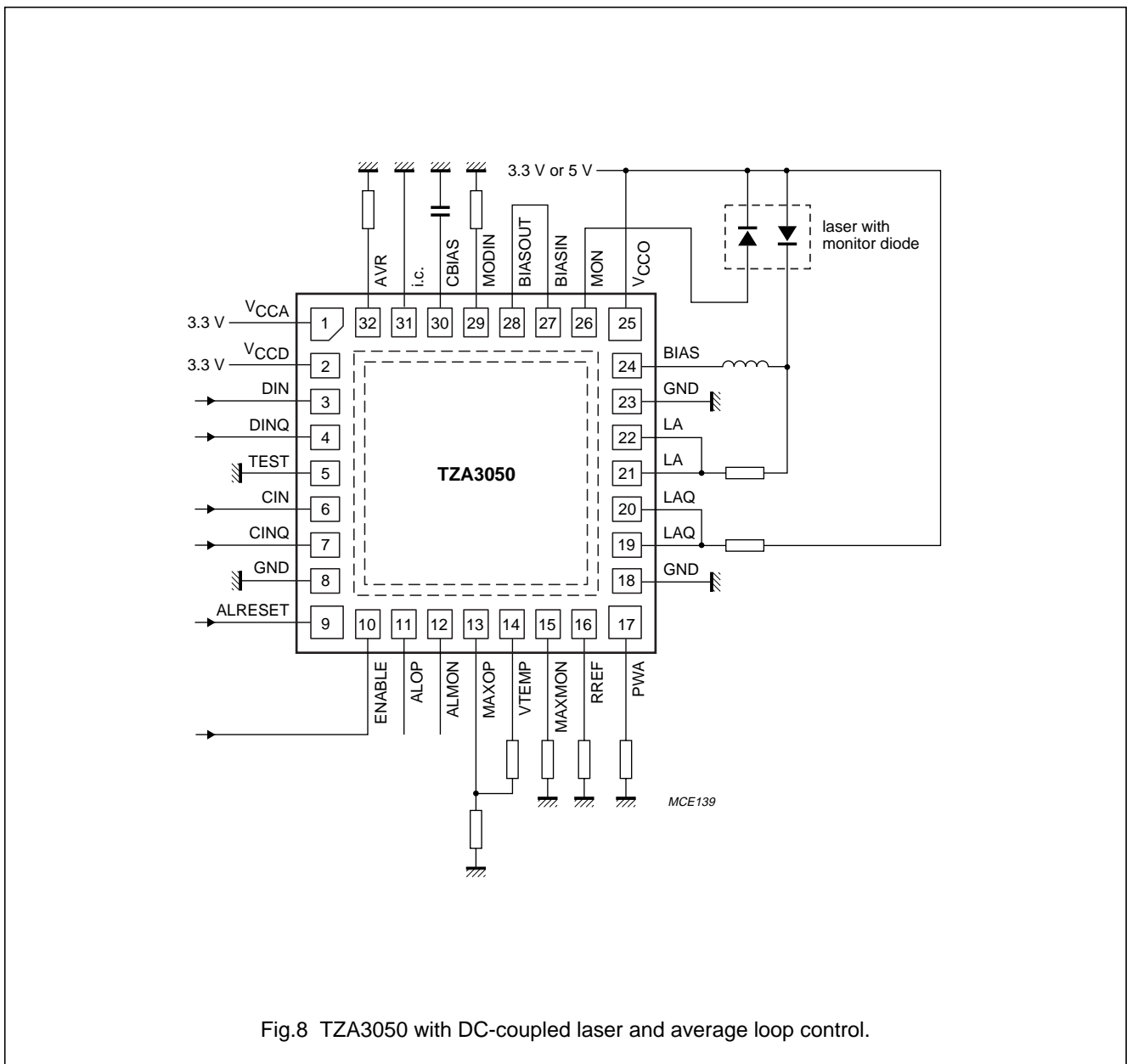

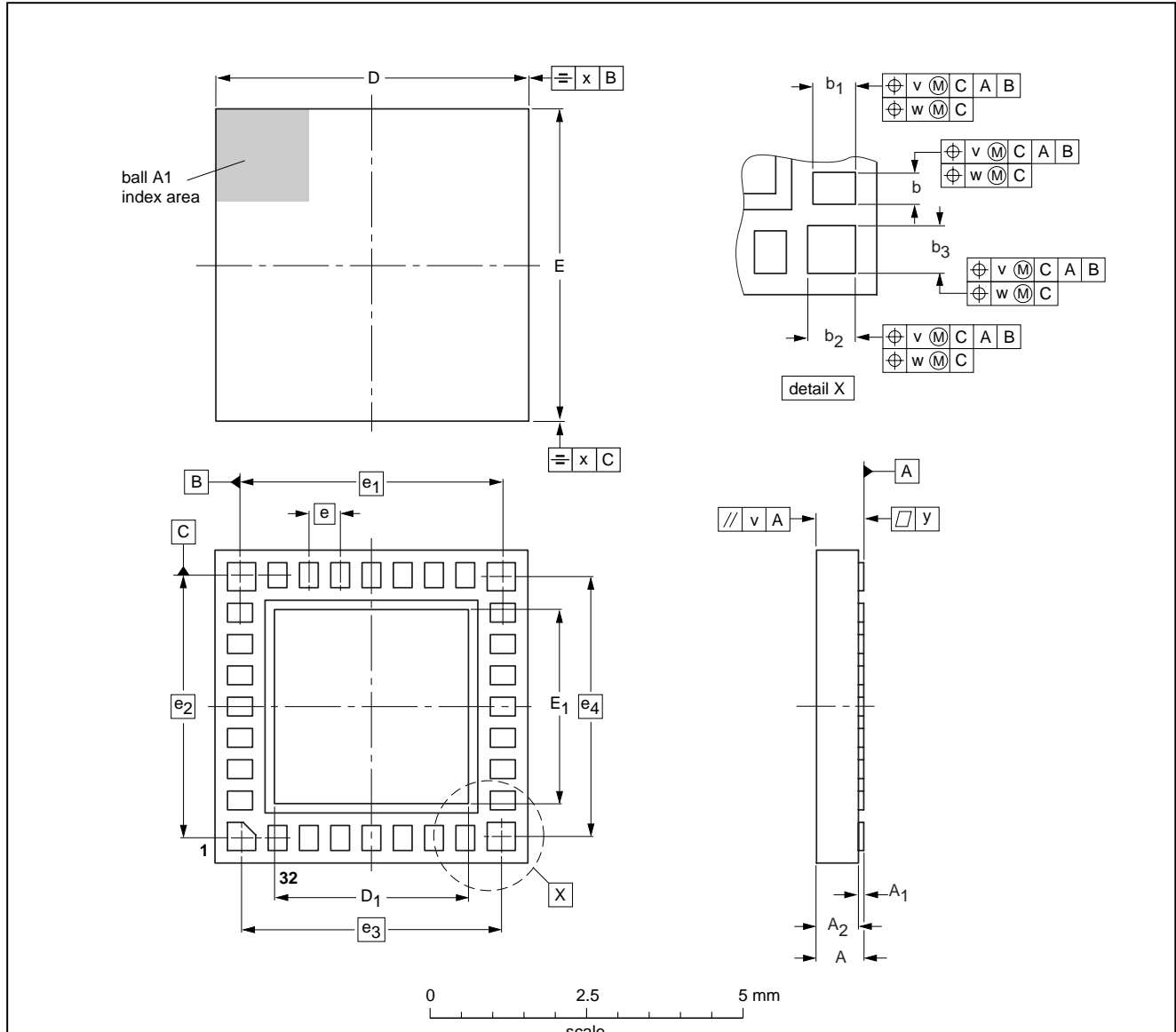Fig.8 TZA3050 with DC-coupled laser and average loop control.

30 Mbits/s up to 1.25 Gbits/s
burst mode laser driver

TZA3050

13 PACKAGE OUTLINE

HBCC32: plastic thermal enhanced bottom chip carrier; 32 terminals; body 5 x 5 x 0.65 mm   **SOT560-1**

ball A1
index area

detail X

0   2.5   5 mm
scale

DIMENSIONS (mm are the original dimensions)

UNIT	A max.	A$_1$	A$_2$	b	b$_1$	b$_2$	b$_3$	D	D$_1$	E	E$_1$	e	e$_1$	e$_2$	e$_3$	e$_4$	v	w	x	y
mm	0.8	0.10 0.05	0.7 0.6	0.35 0.20	0.5 0.3	0.50 0.35	0.50 0.35	5.1 4.9	3.2 3.0	5.1 4.9	3.2 3.0	0.5	4.2	4.2	4.15	4.15	0.2	0.15	0.15	0.05

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	JEITA			
SOT560-1		MO-217				~~00-02-01~~ 03-03-12

14 SOLDERING

14.1 Introduction to soldering surface mount packages

This text gives a very brief insight to a complex technology. A more in-depth account of soldering ICs can be found in our *"Data Handbook IC26; Integrated Circuit Packages"* (document order number 9398 652 90011).

There is no soldering method that is ideal for all surface mount IC packages. Wave soldering can still be used for certain surface mount ICs, but it is not suitable for fine pitch SMDs. In these situations reflow soldering is recommended.

14.2 Reflow soldering

Reflow soldering requires solder paste (a suspension of fine solder particles, flux and binding agent) to be applied to the printed-circuit board by screen printing, stencilling or pressure-syringe dispensing before package placement.

Several methods exist for reflowing; for example, convection or convection/infrared heating in a conveyor type oven. Throughput times (preheating, soldering and cooling) vary between 100 and 200 seconds depending on heating method.

Typical reflow peak temperatures range from 215 to 250 °C. The top-surface temperature of the packages should preferably be kept:

- below 220 °C for all the BGA packages and packages with a thickness $\geq$ 2.5mm and packages with a thickness <2.5 mm and a volume $\geq$350 mm^3 so called thick/large packages

- below 235 °C for packages with a thickness <2.5 mm and a volume <350 mm^3 so called small/thin packages.

14.3 Wave soldering

Conventional single wave soldering is not recommended for surface mount devices (SMDs) or printed-circuit boards with a high component density, as solder bridging and non-wetting can present major problems.

To overcome these problems the double-wave soldering method was specifically developed.

If wave soldering is used the following conditions must be observed for optimal results:

- Use a double-wave soldering method comprising a turbulent wave with high upward pressure followed by a smooth laminar wave.

- For packages with leads on two sides and a pitch (e):
  - larger than or equal to 1.27 mm, the footprint longitudinal axis is **preferred** to be parallel to the transport direction of the printed-circuit board;
  - smaller than 1.27 mm, the footprint longitudinal axis **must** be parallel to the transport direction of the printed-circuit board.

The footprint must incorporate solder thieves at the downstream end.

- For packages with leads on four sides, the footprint must be placed at a 45° angle to the transport direction of the printed-circuit board. The footprint must incorporate solder thieves downstream and at the side corners.

During placement and before soldering, the package must be fixed with a droplet of adhesive. The adhesive can be applied by screen printing, pin transfer or syringe dispensing. The package can be soldered after the adhesive is cured.

Typical dwell time is 4 seconds at 250 °C.
A mildly-activated flux will eliminate the need for removal of corrosive residues in most applications.

14.4 Manual soldering

Fix the component by first soldering two diagonally-opposite end leads. Use a low voltage (24 V or less) soldering iron applied to the flat part of the lead. Contact time must be limited to 10 seconds at up to 300 °C.

When using a dedicated tool, all other leads can be soldered in one operation within 2 to 5 seconds between 270 and 320 °C.

14.5 Suitability of surface mount IC packages for wave and reflow soldering methods

PACKAGE[1]	SOLDERING METHOD	
	WAVE	REFLOW[2]
BGA, LBGA, LFBGA, SQFP, TFBGA, VFBGA	not suitable	suitable
DHVQFN, HBCC, HBGA, HLQFP, HSQFP, HSOP, HTQFP, HTSSOP, HVQFN, HVSON, SMS	not suitable[3]	suitable
PLCC[4], SO, SOJ	suitable	suitable
LQFP, QFP, TQFP	not recommended[4][5]	suitable
SSOP, TSSOP, VSO, VSSOP	not recommended[6]	suitable

Notes

1. For more detailed information on the BGA packages refer to the *"(LF)BGA Application Note"* (AN01026); order a copy from your Philips Semiconductors sales office.

2. All surface mount (SMD) packages are moisture sensitive. Depending upon the moisture content, the maximum temperature (with respect to time) and body size of the package, there is a risk that internal or external package cracks may occur due to vaporization of the moisture in them (the so called popcorn effect). For details, refer to the Drypack information in the *"Data Handbook IC26; Integrated Circuit Packages; Section: Packing Methods"*.

3. These packages are not suitable for wave soldering. On versions with the heatsink on the bottom side, the solder cannot penetrate between the printed-circuit board and the heatsink. On versions with the heatsink on the top side, the solder might be deposited on the heatsink surface.

4. If wave soldering is considered, then the package must be placed at a 45° angle to the solder wave direction. The package footprint must incorporate solder thieves downstream and at the side corners.

5. Wave soldering is suitable for LQFP, TQFP and QFP packages with a pitch (e) larger than 0.8 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.65 mm.

6. Wave soldering is suitable for SSOP, TSSOP, VSO and VSSOP packages with a pitch (e) equal to or larger than 0.65 mm; it is definitely not suitable for packages with a pitch (e) equal to or smaller than 0.5 mm.

30 Mbits/s up to 1.25 Gbits/s
burst mode laser driver

TZA3050

15 DATA SHEET STATUS

LEVEL	DATA SHEET STATUS[1]	PRODUCT STATUS[2][3]	DEFINITION
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
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Notes

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3. For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

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Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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